

**Search Notes**

Application/Control No.

10/674,538

Examiner

Elias Desta

Applicant(s)/Patent under  
Reexamination

KANEKO ET AL.

Art Unit

2857

**SEARCHED**

Class	Subclass	Date	Examiner
702	57,66,75,1 03,104,18 9,195	7/14/2005	E.D
901	46	7/14/2005	E.D
340	665	7/14/2005	E.D
434	113-114	7/14/2005	E.D
84	734	7/14/2005	E.D
73	75,861.06	7/14/2005	E.D
708	5	7/14/2005	E.D

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
702	66,103 189	7/14/2005	E.D
901	46	7/14/2005	E.D
340	665	7/14/2005	E.D
434/113- 114;84/734;73/861.06; 708/5		7/14/2005	E.D

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Method of search: EAST, YAHOO, GOOGLE, IEEE Explore, CRC and PLUS search	7/14/2005	E.D
Consulted: Daniel Wu and Thomas Mullen, class 340, au: 2632	7/14/2005	E.D
Text or key word searches: see attachment	7/14/2005	E.D